MASW4030G

GaAs SPDT Switch DC - 4.0 GHz



Rev. V4

Features

- Absorbtive or Reflective
- Excellent Intermodulation Products
- Excellent Temperature Stability
- Fast Switching Speed: 3 ns Typical
- Ultra Low DC Power Consumption
- Independent Bias Control

Description

The MASW4030G is an SPDT absorptive or reflective GaAs MESFET MMIC. This part combines small size, low insertion loss and power consumption with high isolation. Ideal for many applications and module use. It will function well for designs below 4.0 GHz.

The MASW4030G is fabricated using a mature 1-micron gate length GaAs MESFET process. The process features full chip passivation for increased performance and reliability.

Ordering Information

Part Number	Package		
MASW4030G	DIE		

Absolute Maximum Rating^{1,2}

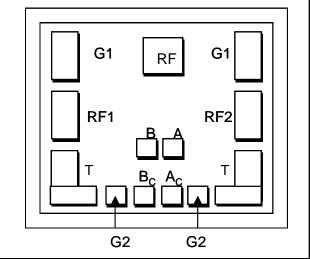
Parameter	Absolute Maximum			
Control Value (A or B)	-8.5 Vdc			
Max Input RF Power	+34.0 dBm (500 MHz - 4 GHz)			
Storage Temperature	-65°C to +175°C			
Operating Temperature	+175°C			

1. Exceeding any one or combination of these limits may cause permanent damage to this device.

 M/A-COM Technology Solutions does not recommend sustained operation near these survivability limits.

1

Pad Layout



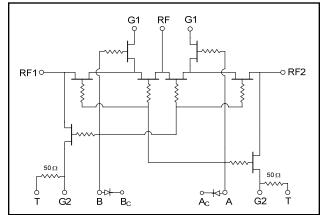
Die Size - Inches (mm)

0.042 x 0.040 x 0.010 (1.065 x 1.015 x 0.25)

Bond Pad Dimensions

Bond Pad	Dimensions - Inches (mm)
G1	0.004 x 0.008 (0.100 x 0.200)
RF1, RF2	0.004 x 0.008 (0.100 x 0.200)
Т	0.0065 x 0.13 (0.165 x 0.330)
A, B, Ac, Bc, G2	0.004 x 0.004 (0.100 x 0.100)
RF	0.008 x 0.006 (0.200 x 0.150)

Schematic



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Electrical Specifications : $T_A = 25^{\circ}C$, $Z_0 = 50 \Omega$, -55°C to +85°C

Parameter	Test Conditions	Units	Min.	Тур.	Max.
Insertion Loss	DC - 1.0 GHz DC - 2.0 GHz DC - 4.0 GHz	dB — — — — — — — — — — — — — — — — — — —		 	0.6 0.8 1.0
Isolation	DC - 1.0 GHz Absorbtive Mode DC - 2.0 GHz Reflective Mode DC - 2.0 GHz DC - 4.0 GHz	orbtive Mode DC - 2.0 GHz dB 50 ective Mode DC - 2.0 GHz dB 42		 	
VSWR	DC - 1.0 GHz DC - 2.0 GHz DC - 4.0 GHz	DC - 2.0 GHz Ratio			1.2:1 1.2:1 1.5:1
Input P-1dB	0.05 GHz (0 / -5 V, 0 / -8 V) 0.5 - 4.0 GHz (0 / -5 V, 0 / -8 V)	dBm		+24, +25 +30, +33	_
IP2	Two Tone Input Power up to +5 dBm 0.05 GHz 0.05 - 4.0 GHz dE		_	62 68	_
IIP3	Two Tone Input Power up to +5 dBm 0.05 GHz 0.05 - 4.0 GHz	dBm		39 46	_
Control Current	V _{IN} Low (0 to - 0.2 V) V _{IN} High (-5 V @ 25 µA Typ. to -8 V)	μΑ		9 75	—
T-rise, T-fall	10% to 90% RF and 90% to 10% RF	ns	_	3	_
T _{on} , T _{off}	50% control to 90% RF, and 50% control to 10% RF	ns	_	6	_

Truth Table

Condition of Switch			Control Inputs			Condition of Bond Pad		
Condition of Switch	А	В	т	G1	G2	RF1	RF2	
Absorbtive	V _{IN} Low	V _{IN} Hi	GND	GND		On	Off	
SPDT	V _{IN} Hi	V _{IN} Low	GND	GND		Off	On	
Reflective	V _{IN} Low	V _{IN} Hi		GND	GND	On	Off	

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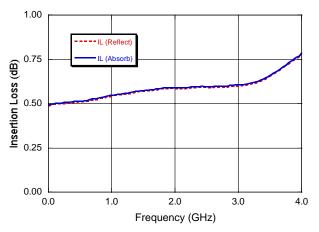
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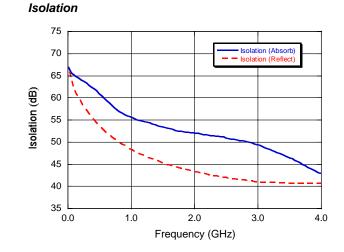


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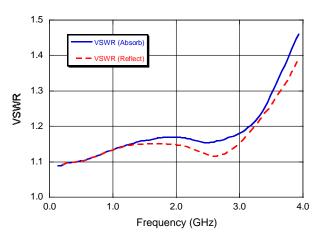
Typical Performance @ 25°C

Insertion Loss





VSWR



Handling Procedures

Please observe the following precautions to avoid damage:

Static Sensitivity

Gallium Arsenide Integrated Circuits are sensitive to electrostatic discharge (ESD) and can be damaged by static electricity. Proper ESD control techniques should be used when handling these devices.

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Handling Precautions

Permanent damage to the MASW4030G may occur if the following precautions are not adhered to:

- A. Cleaniness—MASW4030G should be handled in a clean environment. DO NOT attempt to clean unit after the MASW3040G is installed.
- B. Static Sensitivity—All chip handling equipment and personnel should be DC grounded.
- C. Transient—Avoid instrument and power supply transients while bias is applied to the MASW4030G. Use shielded signal and bias cables to minimize inductive pick-up.
- D. Bias—Apply voltage to either of the complementary control ports only when the other is grounded. No port should be allowed to "float".
- E. General Handling—It is recommended that the MASW4030G chip be handled along the long side of the die with a sharp pair of bent tweezers. DO NOT touch the surface of the chip with fingers or tweezers.

Mounting

The MASW4030G is back-metalized with pd/ni/au (100/1,000, 10,000 Å) metallization. It can be die-mounted with AuSn eutectic preforms or with thermally conductive epoxy. The package surface should be clean and flat before attachment.

Eutectic Die Attach:

- A. A 80/20 gold/tin preform is recommended with a work surface temperature of approximately 255°C and a tool temperature of 265°C. When not 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be approximately 290°C.
- B. DO NOT expose the MASW4030G to a temperature greater than 320°C for more than 20 seconds. No more than 3 seconds for scrubbing should be required for attachment.

Epoxy Die Attach:

- A. Apply a minimum amount of epoxy and place the MASW4030G into position. A thin epoxy fillet should be visible around the perimeter of the chip.
- B. Cure epoxy per manufacturer's recommended schedule.
- C. Electrically conductive epoxy may be used by is not required.

Wire Bonding

- A. Ball or wedge with 1.0 mil diameter pure gold wire. Thermosonic wirebonding with a nominal stage temperature of 150°C and a ball bonding force of 40 to 50 grams or wedge bonding force o1 18 to 22 grams is recommended. Ultrasonic energy and time should be adjusted to the minimum levels achieve reliable wirebonds.
- B. Wirebonds should be started on the chip and terminated on the package. GND bonds should be as short as possible; at least three and no more than four bond wires from ground pads to package are recommended.

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